

**Search Notes**

Application/Control No.

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Examiner

Hai H. Huynh

Applicant(s)/Patent under  
Reexamination

BIDNER ET AL.

Art Unit

3747

**SEARCHED**

Class	Subclass	Date	Examiner
123	329	8/23/2005	HHH
123	406.53	8/23/2005	HHH
123	406.72	8/23/2005	HHH
123	406.47	8/23/2005	HHH
123	443	8/23/2005	HHH
123	481	8/23/2005	HHH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	8/23/2005	HHH